MSCSM70TAM10CTPAG Datasheet Triple Phase Leg SiC MOSFET Power Module

April 2020





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1 Revision History

The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

1.1 Revision 1.0

Revision 1.0 was published in April 2020. It is the first publication of this document.



2 Product Overview

The MSCSM70TAM10CTPAG device is a triple phase leg 700 V/238 A full silicon carbide (SiC) power module.

Figure 1 • MSCSM70TAM10CTPAG Electric Schematic

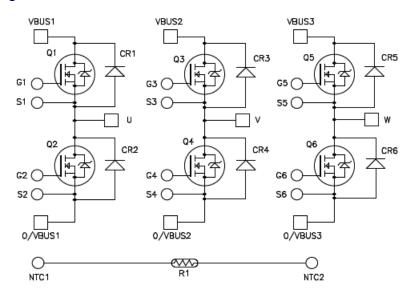
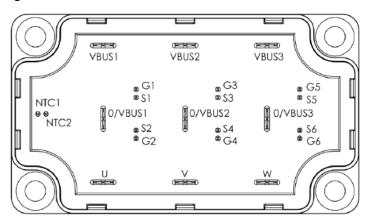


Figure 2 • MSCSM70TAM10CTPAG Pinout Location



All ratings at $T_J = 25$ °C, unless otherwise specified.

Caution: These devices are sensitive to electrostatic discharge. Proper handling procedures should be followed.



2.1 Features

The following are key features of the MSCSM70TAM10CTPAG device:

- SiC Power MOSFET
 - Low R_{DS(on)}
 - High-speed switching
 - Ultra low loss
- SiC Schottky Diode
 - Zero reverse recovery
 - Zero forward recovery
 - Temperature independent switching behavior
 - Positive temperature coefficient on VF
- Very low stray inductance
- Kelvin source for easy drive
- Internal thermistor for temperature monitoring
- Aluminum nitride (AIN) substrate for improved thermal performance

2.2 Benefits

The following are benefits of the MSCSM70TAM10CTPAG device:

- · High-efficiency converter
- Outstanding performance at high-frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction-to-case thermal resistance
- Solderable terminals for power and signal, for easy PCB mounting
- Low profile
- RoHS compliant

2.3 Applications

The MSCSM70TAM10CTPAG device is designed for the following applications:

- Uninterruptible power supplies
- Switched mode power supplies
- · EV motor and traction drive
- · Welding converters



3 Electrical Specifications

This section shows the electrical specifications of the MSCSM70TAM10CTPAG device.

3.1 SiC MOSFET Characteristics (Per MOSFET)

The following table shows the absolute maximum ratings per SiC MOSFET of the MSCSM70TAM10CTPAG device.

Table 1 • Absolute Maximum Ratings

Symbol	Parameter	Max Ratings	Unit	
V _{DSS}	Drain-source voltage	rain-source voltage		
I _D	Continuous drain current	T _C = 25 °C	238 ¹	A
		T _C = 80 °C		
I _{DM}	Pulsed drain current			
V _{GS}	Gate-source voltage		-10/25	V
R _{DSon}	Drain-source ON resistance	9.5	mΩ	
P _D	Power dissipation	T _C = 25 °C	674	W

Note:

1. Specification of the SiC MOSFET device, but output current must be limited due to size of power connectors.

The following table shows the electrical characteristics per SiC MOSFET of the MSCSM70TAM10CTPAG device.

Table 2 • Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I _{DSS}	Zero gate voltage drain current	V _{GS} = 0 V; V _{DS} = 700 V				200	μΑ
R _{DS(on)}	Drain-source on resistance $V_{GS} = 20 \text{ V}$ $I_D = 80 \text{ A}$		T _J = 25 °C		7.5	9.5	mΩ
		$I_D = 80 \text{ A}$ $T_J = 175 \text{ °C}$			9.5		
V _{GS(th)}	Gate threshold voltage	$V_{GS} = V_{DS}$, $I_D = 8 \text{ mA}$		1.9	2.4		V
I _{GSS}	Gate-source leakage current	V _{GS} = 20 V, V _{DS} = 0 V				200	nA



The following table shows the dynamic characteristics per SiC MOSFET of the MSCSM70TAM10CTPAG device.

Table 3 • Dynamic Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
C _{iss}	Input capacitance	V _{GS} = 0 V			9000		pF
C _{oss}	Output capacitance	V _{DS} = 700 V f = 1 MHz			1020		
C _{rss}	Reverse transfer capacitance	_			58		
Qg	Total gate charge	V _{GS} = -5 V/20 V	$V_{GS} = -5 \text{ V/20 V}$ $V_{Bus} = 470 \text{ V}$ $I_D = 80 \text{ A}$				nC
Q_{gs}	Gate-source charge						
Q_{gd}	Gate-drain charge				70		-
T _{d(on)}	Turn-on delay time	V _{GS} = -5 V/20 V	V _{GS} = -5 V/20 V				ns
T _r	Rise time	V _{Bus} = 400 V I _D = 160 A; T _J = 150 °C			35		
T _{d(off)}	Turn-off delay time	R_{Gon} = 13.5 Ω; R_{Goff} = 2.4 Ω			50		
T _f	Fall time				20		
E _{on}	Turn on energy	Inductive switching	T _J = 150 °C		1090		μͿ
E _{off}	Turn off energy	$V_{GS} = -5 \text{ V}/20 \text{ V}$ $V_{Bus} = 400 \text{ V}$ $I_D = 160 \text{ A}$ $R_{Gon} = 13.5 \Omega$ $R_{Goff} = 2.4 \Omega$			372		Щ
R _{Gint}	Internal gate resistance				2.8		Ω
R _{thJC}	Junction-to-case thermal resistance					0.222	°C/W

The following table shows the body diode ratings and characteristics per SiC MOSFET of the MSCSM70TAM10CTPAG device.

Table 4 • Body Diode Ratings and Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
V _{SD}	Diode forward voltage	V _{GS} = 0 V; I _{SD} = 80 A		3.4		V
		V _{GS} = -5V ; I _{SD} = 80 A		3.8		
t _{rr}	Reverse recovery time	$I_{SD} = 80 \text{ A; } V_{GS} = -5 \text{ V}$ $V_R = 400 \text{ V; } d_{iF}/dt = 2000 \text{ A/}\mu\text{s}$		38		ns
Q _{rr}	Reverse recovery charge			636		nC
I _{rr}	Reverse recovery current			29.6		А



3.2 SiC Schottky Diode Ratings and Characteristics

The following table shows the SiC Schottky diode ratings and characteristics of the MSCSM70TAM10CTPAG device.

Table 5 • SiC Schottky Diode Ratings and Characteristics (Per SiC Diode)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V _{RRM}	Peak repetitive reverse voltage					700	V
I _{RM}	Reverse leakage current	V _R = 700 V	T _J = 25 °C		30	400	μΑ
			T _J = 175 °C		500		
I _F	DC forward current		T _C = 70 °C		100		Α
V _F	Diode forward voltage	I _F = 100 A	T _J = 25 °C		1.5	1.8	V
			T _J = 175 °C		1.9		
Qc	Total capacitive charge	V _R = 400 V			266		nC
С	Total capacitance	f = 1 MHz, V _R = 200 V			496		pF
		f = 1 MHz, V _R = 400 V			432		
R _{thJC}	Junction-to-case thermal resistance	ermal resistance				0.466	°C/W

3.3 Thermal and Package Characteristics

The following table shows the package characteristics of the MSCSM70TAM10CTPAG device.

Table 6 • Thermal and Package Characteristics

Symbol	Characteristic				Max	Unit
V _{ISOL}	RMS isolation voltage, any terminal to case t = 1 min, 50 Hz/60 Hz					V
Тј	Operating junction temperature range				175	°C
T _{JOP}	Recommended junction temperature under switching conditions			-40	T _{Jmax} -25	
T _{STG}	Storage temperature range			-40	125	
T _C	Operating case temperature			-40	125	
Torque	Mounting torque To heatsink M6				5	N.m
Wt	Package weight				250	g



The following table shows the temperature sensor NTC (see application note *APT0406* on www.microsemi.com) of the MSCSM70TAM10CTPAG device.

Table 7 • Temperature Sensor NTC

Symbol	Characteristic		Min	Тур	Max	Unit
R ₂₅	Resistance at 25 °C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B _{25/85}	T ₂₅ = 298.15 K			3952		К
ΔΒ/Β		T _C = 100 °C		4		%

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature R_T: Thermistor value at T



3.4 Typical SiC MOSFET Performance Curves

This sections shows the typical SiC MOSFET performance curves of the MSCSM70TAM10CTPAG device.

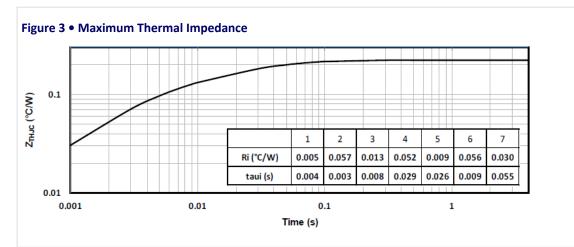


Figure 4 • Output Characteristics, T_J = 25 °C

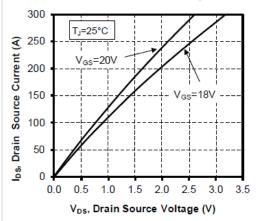


Figure 5 • Output Characteristics, T₁ = 175 °C

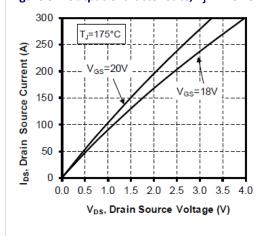


Figure 6 ● Normalized R_{DS(on)} vs. Temperature

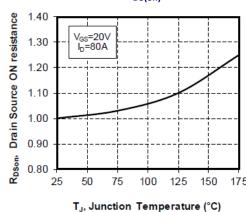


Figure 7 • Transfer Characteristics

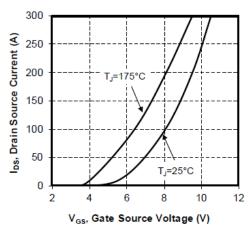




Figure 8 • Capacitance vs. Drain Source Voltage

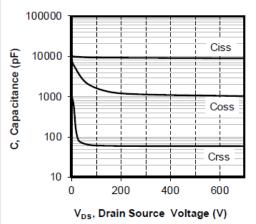


Figure 9 • Gate Charge vs. Gate Source Voltage

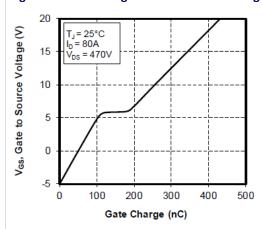


Figure 10 • Body Diode Characteristics, T_J = 25 °C

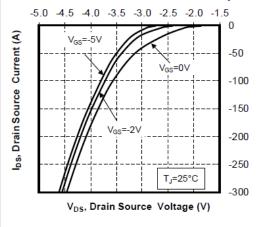


Figure 11 • 3rd Quadrant Characteristics, T_J = 25 °C

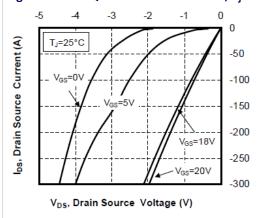


Figure 12 • Body Diode Characteristics, T_J = 175 °C

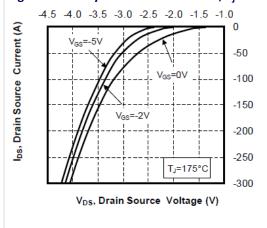


Figure 13 • 3rd Quadrant Characteristics, T_J = 175

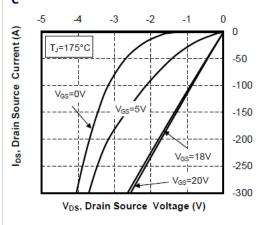
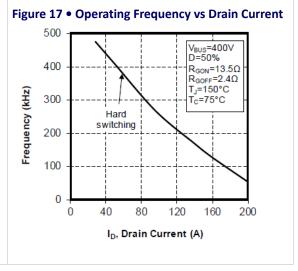




Figure 14 • Switching Energy vs. Current 1400 V_{GS}=-5/20V 1200 Eon $R_{GON}=13.5\Omega$ $R_{GOFF}=2.4\Omega$ 1000 V_{BUS}= 400V Losses (µJ) T_J = 150°C 800 600 Eoff 400 200 0 0 40 80 120 160 200 Current (A)

Figure 15 • Turn On Energy vs. Rg 2200 2000 1800 Losses (µJ) Eon 1600 1400 V_{GS}=-5/20V I_D= 160A V_{BUS} = 400V T_J = 150°C 1200 1000 15 20 25 30 10 Gate Resistance (Ω)

Figure 16 • Turn Off Energy vs. Rg 1200 1000 Eoff 3 800 Losses 600 V_{GS}=-5/20V I_D= 160A 400 V_{BUS} = 400V T_J = 150°C 200 2 2.5 3 3.5 4.5 5 Gate Resistance (Ω)





3.5 Typical SiC Diode Performance Curves

This sections shows the typical SiC diode performance curves of the MSCSM70TAM10CTPAG device.

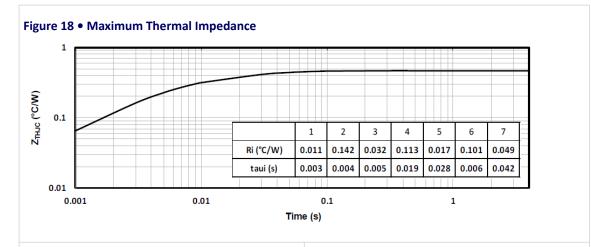


Figure 19 • Forward Characteristics

200

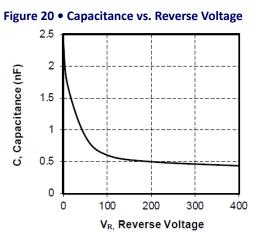
(Y) 160

120

TJ=25°C

TJ=175°C

V_F, Forward Voltage (V)





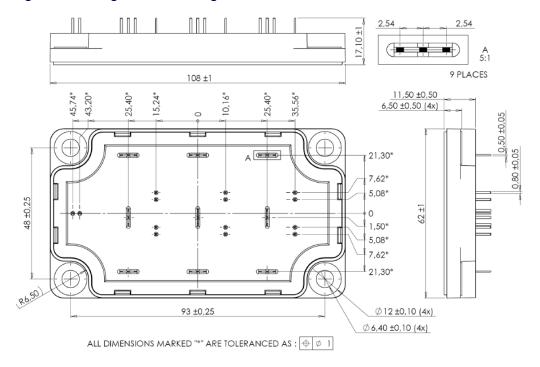
4 Package Specifications

This section shows the package specification of the MSCSM70TAM10CTPAG device.

4.1 Package Outline Drawing

This section shows the package outline drawing of the MSCSM70TAM10CTPAG device. The dimensions in the following figure are in millimeters.

Figure 21 • Package Outline Drawing



Note: See application note 1902 - Mounting Instructions for SP6-P (12 mm) Power Modules on www.microsemi.com.





Microsemi

2355 W. Chandler Blvd. Chandler, AZ 85224 USA

Within the USA: +1 (480) 792-7200 Fax: +1 (480) 792-7277

Fax: +1 (480) 792-7277

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